

Notice of References Cited	Application/Control No. 10/055,811		Applicant(s)/Patent Under Reexamination VEDRUCCIO, CLARBRUNO	
	Examiner Arlen Soderquist		Art Unit 1743	Page 1 of 7

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	Examiner Arlen Soderquist	Art Unit 1743	Page 2 of 7

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	Examiner Arlen Soderquist	Art Unit 1743	Page 3 of 7

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	Examiner Arlen Soderquist	Art Unit 1743	Page 4 of 7

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	Examiner Arlen Soderquist	Art Unit 1743	Page 5 of 7

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	Examiner Arlen Soderquist	Art Unit 1743	Page 6 of 7

U.S. PATENT DOCUMENTS

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	Examiner Arlen Soderquist	Art Unit 1743	Page 7 of 7

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